SCBS777 - NOVEMBER 2003

- Controlled Baseline
 - One Assembly/Test Site, One Fabrication Site
- Enhanced Diminishing Manufacturing Sources (DMS) Support
- Enhanced Product-Change Notification
- Qualification Pedigree[†]
- Member of the Texas Instruments Widebus™ Family
- State-of-the-Art Advanced BiCMOS Technology (ABT) Design for 3.3-V Operation and Low Static-Power Dissipation
- Supports Mixed-Mode Signal Operation (5-V Input and Output Voltages With 3.3-V V_{CC})
- Supports Unregulated Battery Operation Down To 2.7 V
- Typical V_{OLP} (Output Ground Bounce)
 <0.8 V at V_{CC} = 3.3 V, T_A = 25°C
- I_{off} and Power-Up 3-State Support Hot Insertion
- Bus Hold on Data Inputs Eliminates the Need for External Pullup/Pulldown Resistors
- Distributed V_{CC} and GND Pins Minimize High-Speed Switching Noise
- † Component qualification in accordance with JEDEC and industry standards to ensure reliable operation over an extended temperature range. This includes, but is not limited to, Highly Accelerated Stress Test (HAST) or biased 85/85, temperature cycle, autoclave or unbiased HAST, electromigration, bond intermetallic life, and mold compound life. Such qualification testing should not be viewed as justifying use of this component beyond specified performance and environmental limits.

- Flow-Through Architecture Optimizes PCB Layout
- Latch-Up Performance Exceeds 500 mA Per JESD 17
- ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)

DGG PACKAGE (TOP VIEW)

		_		
10E	1	\cup	48	20E
1Y1 [2		47	1A1
1Y2 [3		46	1A2
GND [4		45	GND
1Y3 [5		44] 1A3
1Y4 [6		43] 1A4
v _{cc} [7		42] v _{cc}
2Y1 [8		41	2A1
2Y2 [9		40	2A2
GND [10		39	GND
2Y3 [11		38	2A3
2Y4 [12		37	2A4
3Y1 [13		36	3A1
3Y2 [14		35	3A2
GND [15		34	GND
3Y3 [16		33	3A3
3Y4 [17		32	3A4
v _{cc} [18		31] v _{cc}
4Y1 [19		30] 4A1
4Y2 [20		29	4A2
GND [21		28	GND
4Y3 [_		27] 4A3
4Y4 [_		26] 4 <u>A4</u>
40E	24		25	30E
	_			J

description/ordering information

This 16-bit buffer/driver is designed specifically for low-voltage (3.3-V) V_{CC} operation, but with the capability to provide a TTL interface to a 5-V system environment.

The SN74LVTH16240 is designed specifically to improve both the performance and density of 3-state memory address drivers, clock drivers, and bus-oriented receivers and transmitters.

The device can be used as four 4-bit buffers, two 8-bit buffers, or one 16-bit buffer. The device provides inverting outputs and symmetrical active-low output-enable (OE) inputs.



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SN74LVTH16240-EP 3.3-V ABT 16-BIT BUFFER/DRIVER WITH 3-STATE OUTPUTS

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description/ordering information (continued)

When V_{CC} is between 0 and 1.5 V, the device is in the high-impedance state during power up or power down. However, to ensure the high-impedance state above 1.5 V, \overline{OE} should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

Active bus-hold circuitry is provided to hold unused or floating data inputs at a valid logic level.

This device is fully specified for hot-insertion applications using I_{off} and power-up 3-state. The I_{off} circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down. The power-up 3-state circuitry places the outputs in the high-impedance state during power up and power down, which prevents driver conflict.

ORDERING INFORMATION

TA	PACKA	GE†	ORDERABLE PART NUMBER	TOP-SIDE MARKING
-40°C to 85°C	TSSOP - DGG	Tape and reel	CLVTH16240IDGGREP	LH16240EP

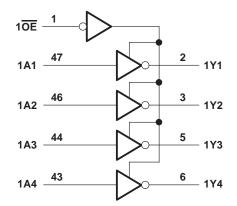
[†] Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

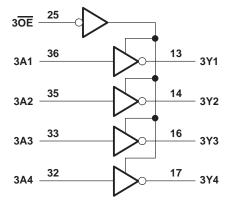
FUNCTION TABLE (each 4-bit buffer)

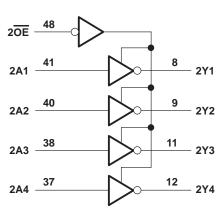
INP	JTS	OUTPUT
OE	Α	Υ
L	Н	L
L	L	Н
Н	Χ	Z

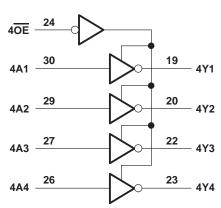


logic diagram (positive logic)









SN74LVTH16240-EP 3.3-V ABT 16-BIT BUFFER/DRIVER WITH 3-STATE OUTPUTS

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage range, V _{CC}	0.5 V to 4.6 V
Input voltage range, V _I (see Note 1)	0.5 V to 7 V
Voltage range applied to any output in the high-impedance	
or power-off state, V _O (see Note 1)	–0.5 V to 7 V
Voltage range applied to any output in the high state, V _O (see Note 1) .	\dots -0.5 V to V _{CC} + 0.5 V
Current into any output in the low state, IO	128 mA
Current into any output in the high state, I _O (see Note 2)	64 mA
Input clamp current, I _{IK} (V _I < 0)	–50 mA
Output clamp current, I _{OK} (V _O < 0)	–50 mA
Package thermal impedance, θ _{JA} (see Note 3)	89°C/W
Storage temperature range, T _{stg}	–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

 - 2. This current flows only when the output is in the high state and $V_O > V_{CC}$.

 3. The package thermal impedance is calculated in accordance with JESD 51.

recommended operating conditions (see Note 4)

				MIN	MAX	UNIT
Vcc	Supply voltage			2.7	3.6	V
V _{IH}	High-level input voltage			2		V
V _{IL}	Low-level input voltage				0.8	V
VI	Input voltage				5.5	V
IOH	High-level output current				-32	mA
loL	Low-level output current				64	mA
Δt/Δν	Input transition rise or fall rate	Outp	outs enabled		10	ns/V
Δt/ΔV _{CC}	Power-up ramp rate			200		μs/V
TA	Operating free-air temperature			-40	85	°C

NOTE 4: All unused control inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PA	RAMETER	TEST CONDITION	S	MIN	TYP†	MAX	UNIT
VIK		V _{CC} = 2.7 V,	$I_{I} = -18 \text{ mA}$			-1.2	V
		$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V},$	$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V},$ $I_{OH} = -100 \mu\text{A}$.2		
Voн		$V_{CC} = 2.7 \text{ V},$	$I_{OH} = -8 \text{ mA}$	2.4			V
		V _{CC} = 3 V,	$I_{OH} = -32 \text{ mA}$	2			
		V 27V	I _{OL} = 100 μA			0.2	
		V _{CC} = 2.7 V	$I_{OL} = 24 \text{ mA}$			0.5	
VOL			I _{OL} = 16 mA			0.4	V
		V _{CC} = 3 V	$I_{OL} = 32 \text{ mA}$			0.5	
			$I_{OL} = 64 \text{ mA}$			0.55	
		$V_{CC} = 0 \text{ or } 3.6 \text{ V},$	$V_{I} = 5.5 V$			10	
١.	Control inputs	V _{CC} = 3.6 V,	$V_I = V_{CC}$ or GND			±1	^
1	Data inputs	V _{CC} = 3.6 V	AI = ACC			1	μΑ
	Data iriputs	VCC = 3.0 V	V _I = 0	_		-5	
l _{off}		$V_{CC} = 0$, $V_I \text{ or } V_O = 0 \text{ to } 4.5 \text{ V}$				±100	μΑ
		V _{CC} = 3 V	V _I = 0.8 V	75			
l(hold)	Data inputs	vCC = 3 v	V _I = 2 V	-75			μΑ
'i(rioid)		V _{CC} = 3.6 V [‡] ,	$V_{I} = 0 \text{ to } 3.6 \text{ V}$			500 -750	
lozh		V _{CC} = 3.6 V,	VO = 3 V			5	μΑ
lozL		V _{CC} = 3.6 V,	V _O = 0.5 V			-5	μΑ
lozpu		$V_{CC} = 0$ to 1.5 V, $V_O = 0.5$ V to 3 V, $\overline{OE} = don$			±100	μΑ	
lozpd		$V_{CC} = 1.5 \text{ V to } 0, V_{O} = 0.5 \text{ V to } 3 \text{ V}, \overline{OE} = \text{don}$	't care			±100	μА
			Outputs high			0.19	
ICC		$V_{CC} = 3.6 \text{ V}, I_{O} = 0, V_{I} = V_{CC} \text{ or GND}$	Outputs low			5	mA
			Outputs disabled			0.19	
ΔI _{CC} §		$V_{CC} = 3 \text{ V to } 3.6 \text{ V}$, One input at $V_{CC} - 0.6 \text{ V}$,			0.2	mA	
Ci		V _I = 3 V or 0		4		pF	
Co		$V_O = 3 V \text{ or } 0$		9		pF	

[†] All typical values are at V_{CC} = 3.3 V, T_A = 25°C. ‡ This is the bus-hold maximum dynamic current. It is the minimum overdrive current required to switch the input from one state to another. § This is the increase in supply current for each input that is at the specified TTL voltage level, rather than V_{CC} or GND.

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switching characteristics over recommended operating free-air temperature range, C_L = 50 pF (unless otherwise noted) (see Figure 1)

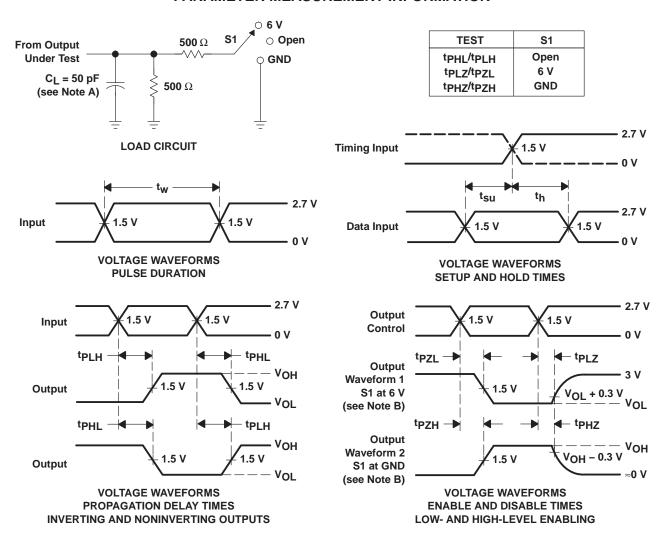
PARAMETER	FROM	V	± 0.3 V	V	VCC =	UNIT		
	(INPUT)	(OUTPUT)	MIN	TYP†	MAX	MIN	MAX	
^t PLH	•	V	1	2.2	3.5		4	
t _{PHL}	A	Y	1	2.7	3.5		4	ns
^t PZH	<u> </u>	V	1	2.6	4		4.9	
tPZL	OE	Y	1.2	2.6	4.4		4.6	ns
^t PHZ	<u>OE</u>	V	2	3.4	4.5		5	
t _{PLZ}	OE .	Y	2	3.2	4.2		4.2	ns
tsk(o)					0.5		0.5	ns

 $^{^{\}dagger}$ All typical values are at VCC = 3.3 V, TA = 25°C.



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PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_O = 50 \Omega$, $t_f \leq$ 2.5 ns, $t_f \leq$ 2.5 ns.
- D. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms





18-Sep-2008

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins P	ackage Qty	e Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
CLVTH16240IDGGREP	ACTIVE	TSSOP	DGG	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
V62/04706-01XE	ACTIVE	TSSOP	DGG	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in

a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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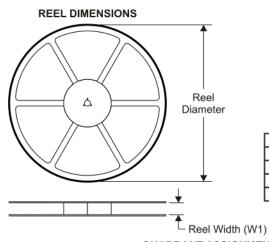
Catalog: SN74LVTH16240

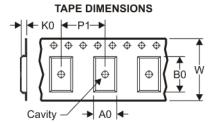
NOTE: Qualified Version Definitions:

Catalog - TI's standard catalog product



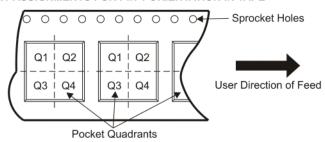
TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device		Package Drawing			Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CLVTH16240IDGGREP	TSSOP	DGG	48	2000	330.0	24.4	8.6	15.8	1.8	12.0	24.0	Q1





*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CLVTH16240IDGGREP	TSSOP	DGG	48	2000	346.0	346.0	41.0

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